

BAT15-02LS

Single silicon RF Schottky diode









Product description

This Infineon RF Schottky diode is a silicon low barrier N-type device with an integrated guard ring on-chip for over-voltage protection. Its low barrier height, low forward voltage and low junction capacitance make BAT15-02LS a suitable choice for mixer and detector functions in applications which frequencies are as high as 12 GHz.



Feature list

- Low inductance L_S = 0.2 nH (typical)
- Low capacitance C = 0.2 pF (typical) at voltage $V_R = 0$ V and frequency f = 1 MHz
- TSSLP-2-1 package (0.62 mm x 0.32 mm x 0.31 mm) with a 0201 foot print
- · Pb-free, RoHS compliant and halogen free

Product validation

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

Potential applications

For mixers and detectors in:

- LiDAR systems
- Radar systems
- Modules and embedded systems

Device information

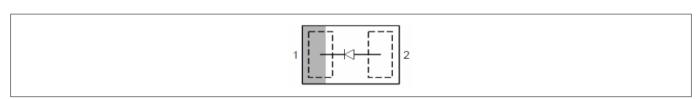


Table 1 Part information

| Product name / Ordering code | Package | Pin configuration | Marking | Pieces / Reel |
|----------------------------------|-----------|-------------------|---------|---------------|
| BAT15-02LS / BAT1502LSE6433XTMA1 | TSSLP-2-1 | Single, leadless | S | 70 k |

Attention: ESD (Electrostatic discharge) sensitive device, observe handling precautions

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1 Absolute maximum ratings

Table 2 Absolute maximum ratings at $T_A = 25$ °C, unless otherwise specified

| Parameter | Symbol | Values | | Unit | Note or test condition |
|-------------------------|----------------|--------|------|------|---------------------------|
| | | Min. | Max. | | |
| Diode reverse voltage | V_{R} | _ | 4 | V | |
| Forward current | / _F | _ | 110 | mA | |
| Total power dissipation | P_{TOT} | _ | 100 | mW | T _S ≤ 82 °C 1) |
| Junction temperature | TJ | _ | 150 | °C | |
| Operating temperature | T_{OP} | -55 | 150 | | |
| Storage temperature | T_{STG} | -55 | 150 | | |

Attention: Stresses above the maximum values listed here may cause permanent damage to the device.

Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Exceeding only one of these values may cause irreversible damage to the component.

 $T_{\rm S}$ is the soldering point temperature.

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Electrical performance in test fixture

Electrical performance in test fixture 2

Electrical characteristics 2.1

Table 3 Electrical characteristics at T_A = 25 °C, unless otherwise specified

| Parameter | Symbol | Values | | | Unit | Note or test condition |
|---------------------------------|----------------|--------|------|------|------|---|
| | | Min. | Тур. | Max. | | |
| Breakdown voltage | V_{BR} | 4 | _ | - | ٧ | / _R = 10 μA |
| Reverse current | I _R | _ | _ | 5 | μΑ | <i>V</i> _R = 1 V |
| Forward voltage | V_{F} | 0.16 | 0.25 | 0.32 | ٧ | / _F = 1 mA |
| | | 0.25 | 0.35 | 0.41 | | / _F = 10 mA |
| Differential forward resistance | R _F | _ | 8 | 10 | Ω | $I_{\rm F} = 10 \text{mA} / 50 \text{mA}^{1}$ |
| Capacitance | С | _ | 0.2 | 0.23 | pF | $V_{R} = 0 \text{ V}, f = 1 \text{ MHz}$ |
| Inductance | L _S | 0.15 | 0.2 | 0.25 | nН | 2) |

2.2 **Characteristic curves**

At T_A = 25 °C, unless otherwise specified

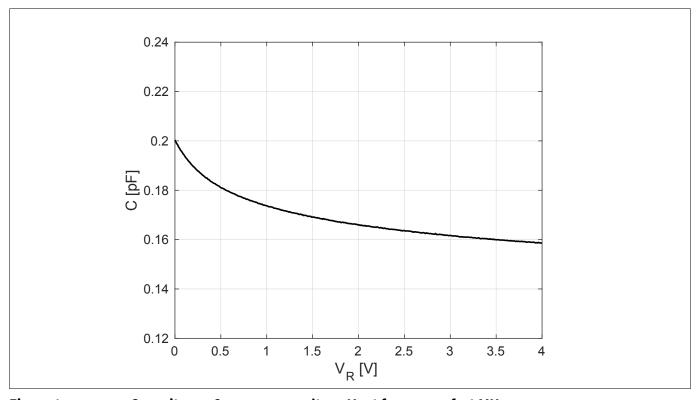


Figure 1 Capacitance C vs. reverse voltage V_R at frequency f = 1 MHz

¹

Parameter is not subject to production test, min/max values are specified by design.

Electrical performance in test fixture

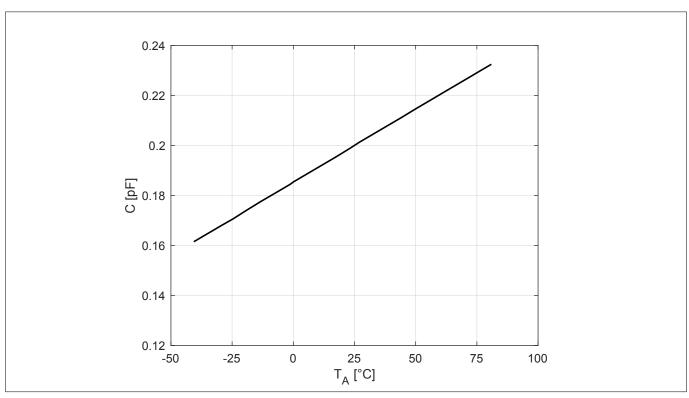


Figure 2 Capacitance C vs. ambient temperature T_A at frequency f = 1 MHz and reverse voltage $V_R = 0$ V

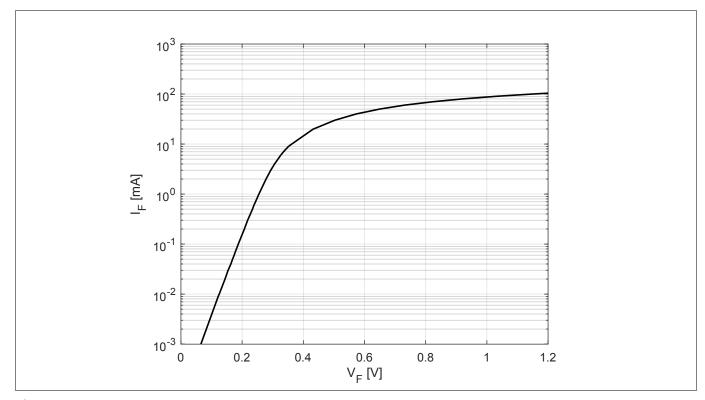


Figure 3 Forward current I_F vs. forward voltage V_F

Electrical performance in test fixture

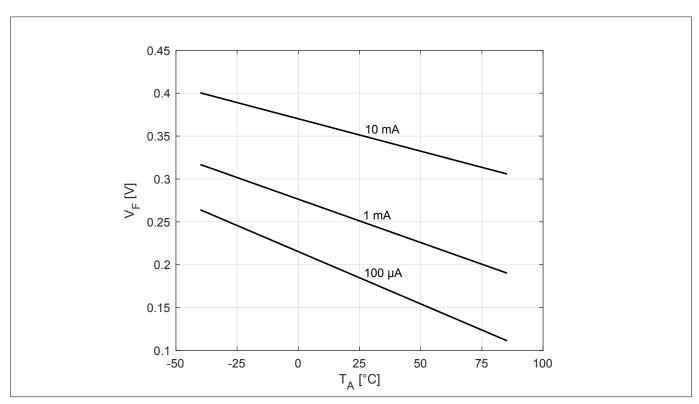


Figure 4 Forward voltage V_F vs. ambient temperature T_A at different forward currents

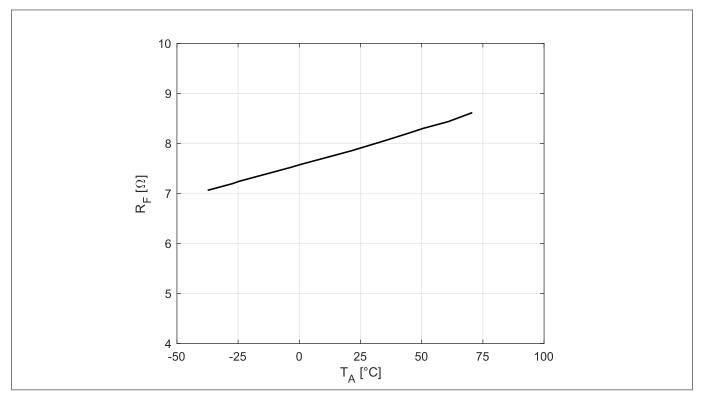


Figure 5 Differential forward resistance R_F vs. ambient temperature T_A between forward currents $I_F = 10$ mA and 50 mA

Electrical performance in test fixture

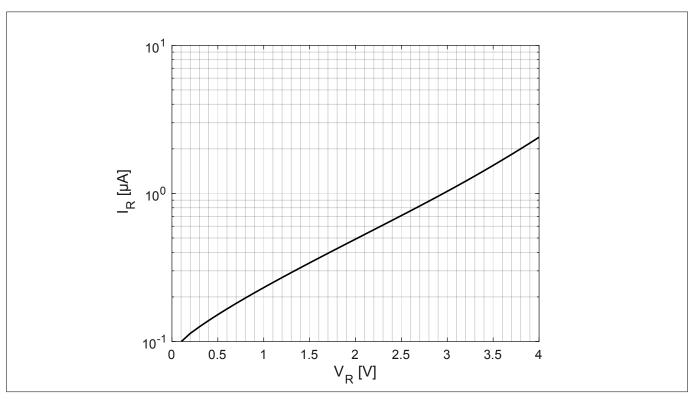


Figure 6 Reverse current I_R vs. reverse voltage V_R

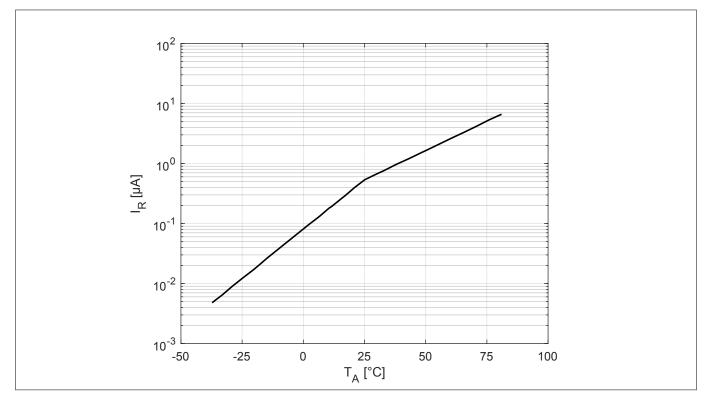


Figure 7 Reverse current I_R vs. ambient temperature T_A at reverse voltage $V_R = 1 \text{ V}$

Note: The curves shown in this chapter have been generated using typical devices but shall not be understood as a guarantee that all devices have identical characteristic curves.

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Thermal characteristics

Thermal characteristics 3

Table 4 Thermal resistance

| Parameter | Sym | Values | | | Unit | Note or test condition |
|------------------------------|-------------------|--------|------|------|------|---------------------------|
| | bol | Min. | Тур. | Max. | | |
| Thermal resistance | R _{thJS} | _ | 675 | _ | K/W | T _S = 82 °C 1) |
| (junction - soldering point) | | | | | | |

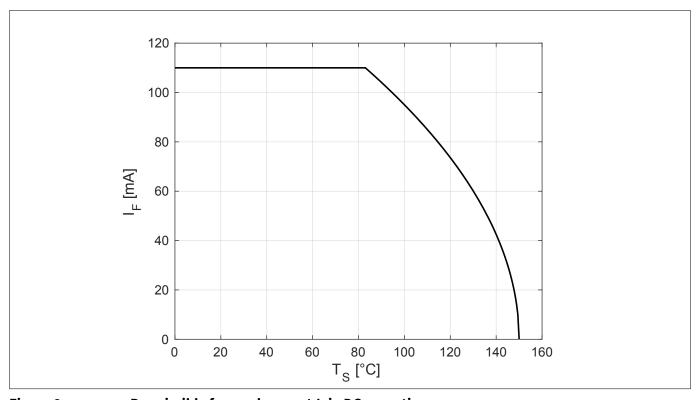


Figure 8 Permissible forward current I_F in DC operation

For R_{thJS} in other conditions refer to the curves in this chapter. 1

Thermal characteristics

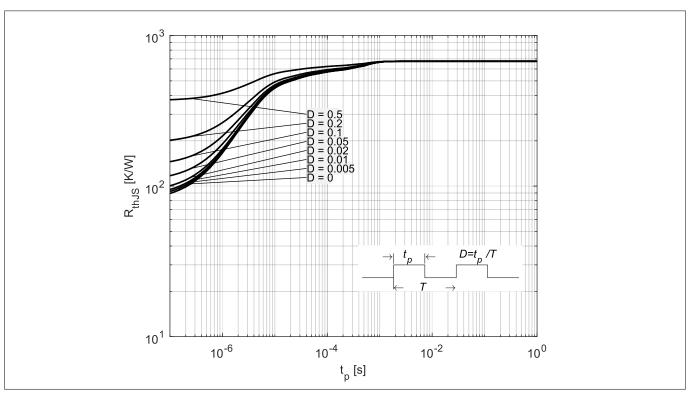


Figure 9 Thermal resistance R_{thJS} in pulse operation

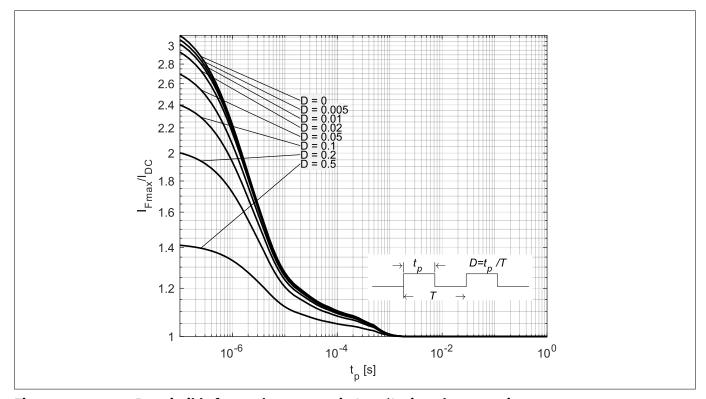


Figure 10 Permissible forward current ratio I_{Fmax}/I_{DC} in pulse operation

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Package information TSSLP-2-1

4 Package information TSSLP-2-1

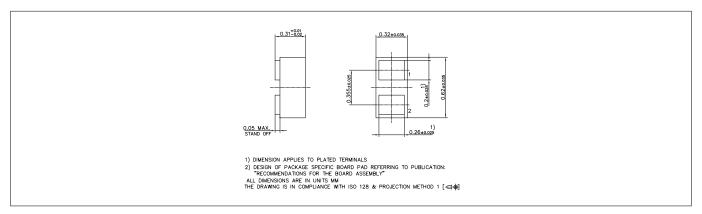


Figure 11 Package outline

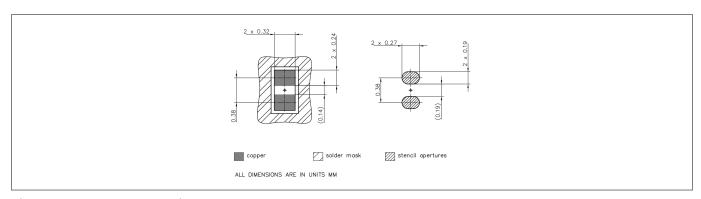


Figure 12 Foot print

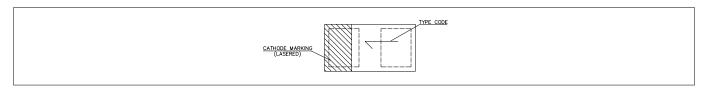


Figure 13 Marking layout example

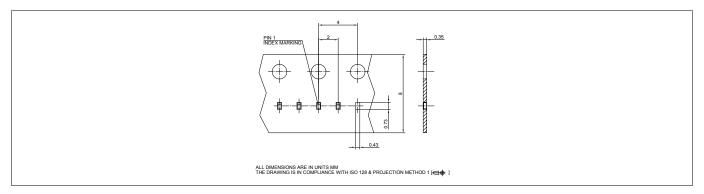


Figure 14 Tape information

Note: See our Recommendations for Printed Circuit Board Assembly of TSLP/TSSLP/TSNP Packages.

The marking layout is an example. For the real marking code refer to the device information on the first page. The number of characters shown in the layout example is not necessarily the real one. The marking layout can consist of less characters.

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References

5 References

[1] Infineon AG - Recommendations for Printed Circuit Board Assembly of Infineon TSLP/TSSLP/TSNP Packages

Revision history

| Document version | Date of release | Description of changes |
|------------------|-----------------|--|
| 2.0 | 2018-09-07 | New layout of datasheet Typical values and curves updated to the values of the production |
| | | (No product or process change behind)Maximum values tightened (No product or process change behind) |

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